

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10711062	CHEN ET AL.
	Examiner	Art Unit
	NHAN T TRAN	2622

SEARCHED

Class	Subclass	Date	Examiner
348	222.1	10/15/2007	NT
348	231.99	10/16/2007	NT
348	241, 425.2	4/2/2008	NT

SEARCH NOTES

Search Notes	Date	Examiner
EAST search (USPAT, PGPUB, JPO, EPO, DERWENT, IBM_TDB)	10/15/2007	NT
348/231.1-231.99 and 348/211.1-211.14 (text search - see search history)	10/16/2007	NT
348/14.12, 14.13 (text search - see search history)	4/2/2008	NT
375/240.27 (text search - see search history)	4/2/2008	NT

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner